

2GB DDR3 SDRAM SO-DIMM

EBJ21UE8BFU0 (256M words × 64 bits, 2 Ranks)

Specifications

- Density: 2GB
- Organization
- 256M words × 64 bits, 2 ranks
- Mounting 16 pieces of 1G bits DDR3 SDRAM sealed in FBGA
- Package: 204-pin socket type small outline dual in line memory module (SO-DIMM)
- PCB height: 30.0mm
- Lead pitch: 0.6mm
- Lead-free (RoHS compliant) and Halogen-free
- Power supply: $VDD = 1.5V \pm 0.075V$
- Data rate: 1600Mbps/1333Mbps (max.) Backward compatible to1066Mbps/800Mbps/667Mbps
- Eight internal banks for concurrent operation (components)
- Interface: SSTL_15
- Burst lengths (BL): 8 and 4 with Burst Chop (BC)
- /CAS Latency (CL): 5, 6, 7, 8, 9, 10, 11
- /CAS write latency (CWL): 5, 6, 7, 8
- Precharge: auto precharge option for each burst access
- Refresh: auto-refresh, self-refresh
- Refresh cycles
- Average refresh period
 7.8µs at 0°C ≤ TC ≤ +85°C
 3.9µs at +85°C < TC ≤ +95°C
- Operating case temperature range
- TC = 0°C to +95°C

Features

- Double-data-rate architecture; two data transfers per clock cycle
- The high-speed data transfer is realized by the 8 bits prefetch pipelined architecture
- Bi-directional differential data strobe (DQS and /DQS) is transmitted/received with data for capturing data at the receiver
- DQS is edge-aligned with data for READs; centeraligned with data for WRITEs
- Differential clock inputs (CK and /CK)
- DLL aligns DQ and DQS transitions with CK transitions
- Commands entered on each positive CK edge; data and data mask referenced to both edges of DQS
- Data mask (DM) for write data
- Posted /CAS by programmable additive latency for better command and data bus efficiency
- On-Die-Termination (ODT) for better signal quality
- Synchronous ODT
- Dynamic ODT
- Asynchronous ODT
- Multi Purpose Register (MPR) for pre-defined pattern read out
- ZQ calibration for DQ drive and ODT
- Programmable Partial Array Self-Refresh (PASR)
- /RESET pin for Power-up sequence and reset
- function
- SRT range:
- Normal/extended
- Programmable Output driver impedance control

Ordering Information

Part number	Data rate Mbps (max.)	Component JEDEC speed bin (CL-tRCD-tRP)	Package	Contact pad	Mounted devices
EBJ21UE8BFU0-GL-F	1600	DDR3-1600J (10-10-10)	204-pin SO-DIMM	Gold	EDJ1108BFBG-GL-F
EBJ21UE8BFU0-GN-F	1600	DDR3-1600K (11-11-11)	(lead-free and halogen-free)		EDJ1108BFBG-GL-F EDJ1108BFBG-GN-F
EBJ21UE8BFU0-DJ-F	1333	DDR3-1333H (9-9-9)	_		EDJ1108BFBG-GL-F EDJ1108BFBG-GN-F EDJ1108BFBG-DJ-F

Detailed Information

For detailed electrical specifications and further information, please refer to the component DDR3 SDRAM datasheet EDJ1108BFBG datasheet (E1629E).

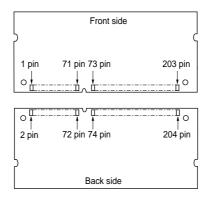
Pin Configurations

Front side Back side		side	Front side		Back side		Front	Front side		Back side	
Pin		Pin		Pin		Pin		Pin		Pin	
No.	Pin name	No.	Pin name	No.	Pin name	No.	Pin name	No.	Pin name	No.	Pin nam
1	VREFDQ	2	VSS	KEY				143	DQ35	144	VSS
3	VSS	4	DQ4	73	CKE0	74	CKE1	145	VSS	146	DQ44
5	DQ0	6	DQ5	75	VDD	76	VDD	147	DQ40	148	DQ45
7	DQ1	8	VSS	77	NC	78	NC	149	DQ41	150	VSS
9	VSS	10	/DQS0	79	BA2	80	NC	151	VSS	152	/DQS5
11	DM0	12	DQS0	81	VDD	82	VDD	153	DM5	154	DQS5
13	VSS	14	VSS	83	A12(/BC)	84	A11	155	VSS	156	VSS
15	DQ2	16	DQ6	85	A9	86	A7	157	DQ42	158	DQ46
17	DQ3	18	DQ7	87	VDD	88	VDD	159	DQ43	160	DQ47
19	VSS	20	VSS	89	A8	90	A6	161	VSS	162	VSS
21	DQ8	22	DQ12	91	A5	92	A4	163	DQ48	164	DQ52
23	DQ9	24	DQ13	93	VDD	94	VDD	165	DQ49	166	DQ53
25	VSS	26	VSS	95	A3	96	A2	167	VSS	168	VSS
27	/DQS1	28	DM1	97	A1	98	A0	169	/DQS6	170	DM6
29	DQS1	30	/RESET	99	VDD	100	VDD	171	DQS6	172	VSS
31	VSS	32	VSS	101	CK0	102	CK1	173	VSS	174	DQ54
33	DQ10	34	DQ14	103	/CK0	104	/CK1	175	DQ50	176	DQ55
35	DQ11	36	DQ15	105	VDD	106	VDD	177	DQ51	178	VSS
37	VSS	38	VSS	107	A10(AP)	108	BA1	179	VSS	180	DQ60
39	DQ16	40	DQ20	109	BA0	110	/RAS	181	DQ56	182	DQ61
41	DQ17	42	DQ21	111	VDD	112	VDD	183	DQ57	184	VSS
43	VSS	44	VSS	113	/WE	114	/CS0	185	VSS	186	/DQS7
45	/DQS2	46	DM2	115	/CAS	116	ODT0	187	DM7	188	DQS7
47	DQS2	48	VSS	117	VDD	118	VDD	189	VSS	190	VSS
49	VSS	50	DQ22	119	A13	120	ODT1	191	DQ58	192	DQ62
51	DQ18	52	DQ23	121	/CS1	122	NC	193	DQ59	194	DQ63
53	DQ19	54	VSS	123	VDD	124	VDD	195	VSS	196	VSS
55	VSS	56	DQ28	125	NC	126	VREFCA	197	SA0	198	NC
57	DQ24	58	DQ29	127	VSS	128	VSS	199	VDDSPD	200	SDA
59	DQ25	60	VSS	129	DQ32	130	DQ36	201	SA1	202	SCL
61	VSS	62	/DQS3	131	DQ33	132	DQ37	203	VTT	204	VTT
63	DM3	64	DQS3	133	VSS	134	VSS	_			
65	VSS	66	VSS	135	/DQS4	136	DM4	_			
67	DQ26	68	DQ30	137	DQS4	138	VSS	_			
69	DQ27	70	DQ31	139	VSS	140	DQ38	_			
71	VSS	72	VSS	141	DQ34	142	DQ39	-			

Pin Description

Pin name	Function
A0 to A13	Address inputRow addressA0 to A13Column addressA0 to A9
A10 (AP)	Auto precharge
A12 (/BC)	Burst chop
BA0, BA1, BA2	Bank select address
/RAS	Row address strobe
/CAS	Column address strobe
/WE	Write enable
/CS0, /CS1	Chip select
CKE0, CKE1	Clock enable
CK0, CK1	Clock input
/CK0, /CK1	Differential clock input
ODT0, ODT1	ODT control
DQ0 to DQ63	Data input/output
DQS0 to DQS7, /DQS0 to /DQS7	Input and output data strobe
DM0 to DM7	Input mask
SCL	Clock input for serial PD
SDA	Data input/output for serial PD
SA0, SA1	Address input for serial PD
VDD*1	Power for internal circuit
VDDSPD	Power for serial PD
VREFCA	Reference voltage for CA
VREFDQ	Reference voltage for DQ
VSS	Ground
VTT	I/O termination supply for SDRAM
/RESET	Set DRAM to a known state
NC	No connection

Note: 1. The VDD and VDDQ pins are tied common to a single power-plane on these designs.



Serial PD Matrix

		-DJ		-GN		-GL	
Byte No.	Function described	Hex	Comments	Hex	Comments	Hex	Comments
0	Number of serial PD bytes written/ SPD device size/CRC coverage	92h	176/256/0-116	92h	176/256/0-116	92h	176/256/0-116
1	SPD revision	10h	Rev.1.0	10h	Rev.1.0	10h	Rev.1.0
2	Key byte/DRAM device type	0Bh	DDR3 SDRAM	0Bh	DDR3 SDRAM	0Bh	DDR3 SDRAM
3	Key byte/module type	03h	SO-DIMM	03h	SO-DIMM	03h	SO-DIMM
4	SDRAM density and banks	02h	1G bits, 8 banks	02h	1G bits, 8 banks	02h	1G bits, 8 banks
5	SDRAM addressing	11h	14 rows, 10 columns	11h	14 rows, 10 columns	11h	14 rows, 10 columns
6	Module nominal voltage, VDD	00h	1.5V	00h	1.5V	00h	1.5V
7	Module organization	09h	2 ranks/×8 bits	09h	2 ranks/×8 bits	09h	2 ranks/×8 bits
8	Module memory bus width	03h	64 bits/non-ECC	03h	64 bits/non-ECC	03h	64 bits/non-ECC
9	Fine timebase (FTB) dividend/divisor	52h	5/2	52h	5/2	52h	5/2
10	Medium timebase (MTB) dividend	01h	1	01h	1	01h	1
11	Medium timebase (MTB) divisor	08h	8	08h	8	08h	8
12	SDRAM minimum cycle time (tCK (min.))	0Ch	1.5ns	0Ah	1.25ns	0Ah	1.25ns
13	Reserved	00h	_	00h	_	00h	_
14	SDRAM CAS latencies supported, LS	B7Eh	5, 6, 7, 8, 9, 10	FEh	5, 6, 7, 8, 9, 10, 11	FEh	5, 6, 7, 8, 9, 10, 11
15	SDRAM CAS latencies supported, MSB	00h	_	00h	_	00h	_
16	SDRAM minimum CAS latencies time (tAA (min.))	69h	13.125ns	69h	13.125ns	64h	12.5ns
17	SDRAM minimum write recovery time (tWR (min.))	78h	15ns	78h	15ns	78h	15ns
18	SDRAM minimum /RAS to /CAS delay (tRCD (min.))	69h	13.125ns	69h	13.125ns	64h	12.5ns
19	SDRAM minimum row active to row active delay (tRRD (min.))	30h	6ns	30h	6ns	30h	6ns
20	SDRAM minimum row precharge time (tRP (min.))	69h	13.125ns	69h	13.125ns	64h	12.5ns
21	SDRAM upper nibbles for tRAS and tRC	11h	_	11h	_	11h	_
22	SDRAM minimum active to precharge time (tRAS (min.)), LSB	20h	36ns	18h	35ns	18h	35ns
23	SDRAM minimum active to active /auto-refresh time (tRC (min.)), LSB	89h	49.125ns	81h	48.125ns	7Ch	47.5ns
24	SDRAM minimum refresh recovery time delay (tRFC (min.)), LSB	70h	110ns	70h	110ns	70h	110ns
25	SDRAM minimum refresh recovery time delay (tRFC (min.)), MSB	03h	110ns	03h	110ns	03h	110ns
26	SDRAM minimum internal write to read command delay (tWTR (min.))	3Ch	7.5ns	3Ch	7.5ns	3Ch	7.5ns
27	SDRAM minimum internal read to precharge command delay (tRTP (min.))	3Ch	7.5ns	3Ch	7.5ns	3Ch	7.5ns
28	Upper nibble for tFAW	00h	30ns	00h	30ns	00h	30ns
29	Minimum four activate window delay time (tFAW (min.))	F0h	30ns	F0h	30ns	F0h	30ns
30	SDRAM optional features	83h	DLL-off, RZQ/6, 7	83h	DLL-off, RZQ/6, 7	83h	DLL-off, RZQ/6, 7
31	SDRAM thermal and refresh options	81h	PASR/2X refresh at +85°C to +95°C	81h	PASR/2X refresh at +85°C to +95°C	81h	PASR/2X refresh at +85°C to +95°C

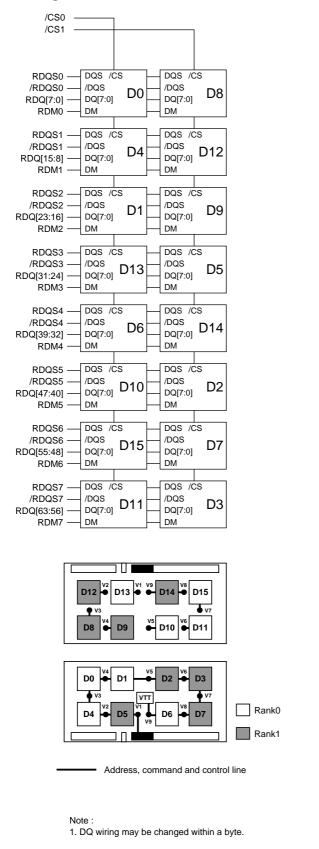
Data Sheet E1642E30 (Ver. 3.0)

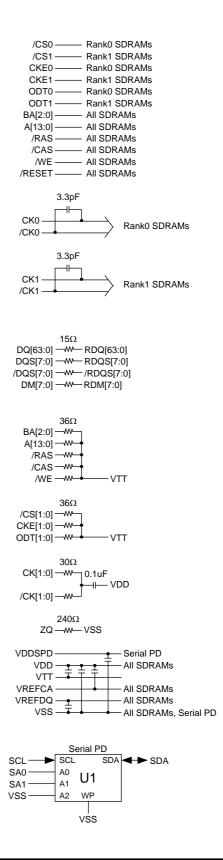
ΕLΡΙDΛ

EBJ21UE8BFU0

Byte No. Function described Hex Comments Hex Comments Hex Comments 32 Module thermal sensor 00h Not incorporated 00h Not incorporated 00h Standard 00h - 00h - <th></th> <th></th> <th>-DJ</th> <th></th> <th>-GN</th> <th></th> <th>-GL</th> <th></th>			-DJ		-GN		-GL	
33 SDRAM device type 00h Standard 00h - - 00h - - - - - - -	Byte No.	Function described	Hex	Comments	Hex	Comments	Hex	Comments
24 to 59 Reserved Oth — Oth — Oth — 60 Module nominal height OFh 29 < height ≤ 30mm	32	Module thermal sensor	00h	Not incorporated	00h	Not incorporated	00h	Not incorporated
60 Module nominal height 0Fh 29 < height ≤ 30mm 0Fh 29 < height ≤ 30mm 0Fh 29 < height ≤ 30mm 61 Module maximum thickness 11h Dual sides 00h - 00h	33	SDRAM device type	00h	Standard	00h	Standard	00h	Standard
61 Module maximum thickness 11h Dual sides 11h Dual sides 11h Dual sides 62 Reference raw card used 25h Raw Card F1 25h Raw Card F1 </td <td>34 to 59</td> <td>Reserved</td> <td>00h</td> <td>_</td> <td>00h</td> <td>_</td> <td>00h</td> <td>_</td>	34 to 59	Reserved	00h	_	00h	_	00h	_
62 Reference raw card used 25h Raw Card F1 25h	60	Module nominal height	0Fh	29 < height ≤ 30mm	0Fh	29 < height ≤ 30mm	0Fh	29 < height ≤ 30mm
63 Address mapping from edge connector to DRAM 00h Standard 00h Standard 00h Standard 00h Standard 00h Standard 00h Standard 00h - - 00h - 00h - - 00h - 00h - - 00h - - 00h - - 00h - - - - - - - -	61	Module maximum thickness	11h	Dual sides	11h	Dual sides	11h	Dual sides
onnector ib PRAM oun Standard oun Standard oun Standard oun Standard oun Standard 64 to 116 Reserved 00h - 00h - 00h - 117 Module ID: manufacturer's JEDEC ID code, ISB Elpida Memory FEh Elpida Memory FEh Elpida Memory 118 Module ID: manufacturing location × - ×× - ×× - 120 Module ID: manufacturing date yy Year code (BCD) yy Year code (BCD) yy Year code (BCD) 121 Module ID: manufacturing date yw Week code (BCD) ww Week code (BCD) ww Week code (BCD) 122 to 25 Module D: monufacturing date yw Week code (BCD) ww Week code (BCD) 121 Module D: manufacturing date ww Week code (BCD) ww Week code (BCD) 122 to 25 Kolule part number 42h B 42h B 42h E	62	Reference raw card used	25h	Raw Card F1	25h	Raw Card F1	25h	Raw Card F1
Indule ID: manufacturer's JEDEC ID code, LSB O2h Elpida Memory O2h Elpida Memory O2h Elpida Memory 118 Module ID: manufacturer's JEDEC ID code, MSB FEh Elpida Memory Vac	63		00h	Standard	00h	Standard	00h	Standard
117 ID code, LSB Uch Elpida Memory Uch Elpida Memory Uch Elpida Memory Uch Elpida Memory Elpida Memory 118 Module ID: manufacturing location × - × - × - 119 Module ID: manufacturing location × - × - × - 120 Module ID: manufacturing date yy Year code (BCD) yy Year code (BCD) ww Week code (BCD) Week code (BCD) Week code (BCD) Wodu	64 to 116	Reserved	00h	_	00h	_	00h	_
118 ID code, MSB FEB Elpida Memory Year code (BCD)	117		02h	Elpida Memory	02h	Elpida Memory	02h	Elpida Memory
120 Module ID: manufacturing date yy Year code (BCD) yy Year code (BCD) yy Year code (BCD) 121 Module ID: manufacturing date ww Week code (BCD) ww Week code (BCD) ww Week code (BCD) 122 to 125 Module ID: module serial number ×x - ×x - ×x - 126 Cyclical redundancy code (CRC) F4h - 21h - DAh - 127 Cyclical redundancy code (CRC) 7Fh - A1h - AAh - 128 Module part number 45h E 45h E 45h E 129 Module part number 42h B 42h J 4Ah J 130 Module part number 32h 2 32h	118		FEh	Elpida Memory	FEh	Elpida Memory	FEh	Elpida Memory
121 Module ID: manufacturing date ww Week code (BCD) ww Week code (BCD) ww Week code (BCD) 122 to 125 Module ID: module serial number ×× - ×× - ×× - 126 Cyclical redundancy code (CRC) F4h - 21h - DAh - 127 Cyclical redundancy code (CRC) F4h - 21h - DAh - 128 Module part number 45h E 45h E 45h E 129 Module part number 42h B 42h J 4Ah J 11 31h 1 31h 1 31h 1 31h 1 11 31s Module part number 32h 2 32h 2 32h 2 32h 1 1	119	Module ID: manufacturing location	××	_	XX	_	XX	_
122 to 125 Module ID: module serial number xx $ xx$ $ xx$ $-$ 126Cyclical redundancy code (CRC)F4h $-$ 21h $-$ DAh $-$ 127Cyclical redundancy code (CRC)7Fh $-$ A1h $-$ AAh $-$ 128Module part number45hE45hE45hE129Module part number42hB42hB42hB130Module part number32h232h232h2132Module part number31h131h131h1133Module part number55hU55hU55hU134Module part number45hE45hE45hE135Module part number42hB42hB42hB136Module part number42hB42hB42hB137Module part number42hB42hB42hB138Module part number30h030h030h0140Module part number44hD47hG47hG138Module part number20h $-$ 20h $-$ 20h $-$ 138Module part number20h $-$ 20h $-$ 20h $-$ 140Module part number20h $-$ 20h $-$ 20h $-$ 141Modu	120	Module ID: manufacturing date	уу	Year code (BCD)	уу	Year code (BCD)	уу	Year code (BCD)
126 Cyclical redundancy code (CRC) F4h — 21h — DAh — 127 Cyclical redundancy code (CRC) 7Fh — A1h — AAh — 128 Module part number 45h E 45h E 45h E 45h E 129 Module part number 42h B 42h B 42h B 130 Module part number 4Ah J 4Ah J 4Ah J 131 Module part number 32h 2 32h 2 32h 2 132 Module part number 31h 1 31h 1 31h 1 133 Module part number 55h U 55h U 55h U 134 Module part number 45h E 45h E 45h E 135 Module part number 42h B 42h B 42h B 136 Module part number 46h F 46h F 46h F	121	Module ID: manufacturing date	ww	Week code (BCD)	ww	Week code (BCD)	ww	Week code (BCD)
127 Cyclical redundancy code (CRC) 7Fh — A1h — AAh — 128 Module part number 45h E 45h E 45h E 129 Module part number 42h B 42h B 42h B 130 Module part number 4Ah J 4Ah J 4Ah J 131 Module part number 32h 2 32h 2 32h 2 132 Module part number 31h 1 31h 1 31h 1 11h 133 Module part number 55h U 55h U 55h U 134 Module part number 45h E 45h E 45h E 135 Module part number 42h B 42h B 42h B 136 Module part number 55h U 55h U 55h U 138 Module part number 30h 0 30h 0 30h 0 140<	122 to 125	Module ID: module serial number	XX	_	XX	_	XX	_
128 Module part number 45h E 45h E 45h E 129 Module part number 42h B 42h B 42h B 130 Module part number 4Ah J 4Ah J 4Ah J 131 Module part number 32h 2 32h 2 32h 2 132 Module part number 31h 1 31h 1 31h 1 133 Module part number 55h U 55h U 55h U 134 Module part number 45h E 45h E 45h E 135 Module part number 48h 8 38h 8 38h 8 136 Module part number 46h F 46h F 46h F 138 Module part number 30h 0 30h 0 30h 0 139 Module part number 20h — 20h — 20h _ 141 Module part numb	126	Cyclical redundancy code (CRC)	F4h	_	21h	_	DAh	_
129 Module part number 42h B 42h B 42h B 130 Module part number 4Ah J 4Ah J 4Ah J 131 Module part number 32h 2 32h 2 32h 2 132 Module part number 31h 1 31h 1 31h 1 133 Module part number 55h U 55h U 55h U 134 Module part number 45h E 45h E 45h E 135 Module part number 38h 8 38h 8 38h 8 136 Module part number 46h F 46h F 46h F 138 Module part number 55h U 55h U 55h U 139 Module part number 2Dh — 2Dh — 2Dh — 141 Module part number 4Dh <td>127</td> <td>Cyclical redundancy code (CRC)</td> <td>7Fh</td> <td>_</td> <td>A1h</td> <td>_</td> <td>AAh</td> <td>_</td>	127	Cyclical redundancy code (CRC)	7Fh	_	A1h	_	AAh	_
130 Module part number 4Ah J 4Ah J 4Ah J 131 Module part number 32h 2 32h 2 32h 2 132 Module part number 31h 1 31h 1 31h 1 133 Module part number 55h U 55h U 55h U 134 Module part number 45h E 45h E 45h E 135 Module part number 38h 8 38h 8 38h 8 136 Module part number 46h F 46h F 46h F 138 Module part number 55h U 55h U 10 10 139 Module part number 20h - 20h - 20h - 140 Module part number 20h - 20h - 20h - 141 Module part number 40h J 4Eh N 4Ch L 143 Module part numb	128	Module part number	45h	E	45h	E	45h	E
131 Module part number 32h 2 32h 2 32h 2 132 Module part number 31h 1 31h 1 31h 1 133 Module part number 55h U 55h U 55h U 134 Module part number 45h E 45h E 45h E 135 Module part number 38h 8 38h 8 38h 8 136 Module part number 42h B 42h B 42h B 137 Module part number 46h F 46h F 46h F 138 Module part number 55h U 55h U 55h U 140 Module part number 20h - 20h - 20h - 141 Module part number 20h - 20h - 20h - 142 Module part number 20h - 20h - 20h - 143 Module part numb	129	Module part number	42h	В	42h	В	42h	В
132 Module part number 31h 1 31h 1 31h 1 133 Module part number 55h U 55h U 55h U 134 Module part number 45h E 45h E 45h E 135 Module part number 38h 8 38h 8 38h 8 136 Module part number 42h B 42h B 42h B 137 Module part number 46h F 46h F 46h F 138 Module part number 55h U 55h U 55h U 139 Module part number 30h 0 30h 0 30h 0 140 Module part number 2Dh - 2Dh - 2Dh - 141 Module part number 4Ah J 4Eh N 4Ch L 142 Module part number 2Dh - 2Dh - 2Dh - 144 Module part numb	130	Module part number	4Ah	J	4Ah	J	4Ah	J
133 Module part number 55h U 55h U 55h U 134 Module part number 45h E 45h E 45h E 135 Module part number 38h 8 38h 8 38h 8 136 Module part number 42h B 42h B 42h B 137 Module part number 46h F 46h F 46h F 138 Module part number 55h U 55h U 55h U 139 Module part number 30h 0 30h 0 30h 0 140 Module part number 20h 20h 20h 141 Module part number 44h D 47h G 47h G 142 Module part number 4Ah J 4Eh N 4Ch L 143 Module part number 20h	131	Module part number	32h	2	32h	2	32h	2
134 Module part number 45h E 45h E 45h E 135 Module part number 38h 8 38h 8 38h 8 136 Module part number 42h B 42h B 42h B 137 Module part number 46h F 46h F 46h F 138 Module part number 55h U 55h U 55h U 139 Module part number 20h - 20h - 20h - 140 Module part number 20h - 20h - 20h - 141 Module part number 44h D 47h G 47h G 142 Module part number 44h D 47h G 47h G 143 Module part number 20h - 20h - 20h - 144 Module part number 20h <td>132</td> <td>Module part number</td> <td>31h</td> <td>1</td> <td>31h</td> <td>1</td> <td>31h</td> <td>1</td>	132	Module part number	31h	1	31h	1	31h	1
135 Module part number 38h 8 38h 8 38h 8 136 Module part number 42h B 42h B 42h B 137 Module part number 46h F 46h F 46h F 138 Module part number 55h U 55h U 55h U 139 Module part number 30h 0 30h 0 30h 0 140 Module part number 2Dh — 2Dh — 2Dh — 141 Module part number 44h D 47h G 47h G 142 Module part number 44h D 47h G 47h L 143 Module part number 44h J 4Eh N 4Ch L 143 Module part number 2Dh — 2Dh — 2Dh — 144 Module part number 20h <td>133</td> <td>Module part number</td> <td>55h</td> <td>U</td> <td>55h</td> <td>U</td> <td>55h</td> <td>U</td>	133	Module part number	55h	U	55h	U	55h	U
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137Module part number46hF46hF46hF138Module part number55hU55hU55hU139Module part number30h030h030h0140Module part number2Dh2Dh2Dh141Module part number44hD47hG47hG142Module part number4AhJ4EhN4ChL143Module part number2Dh2Dh144Module part number46hF46hF145Module part number20h(Space)20h(Space)146Module part number20hSpace)20h(Space)146Module revision code30hInitial30hInitial147Module revision code20h(Space)20h(Space)148SDRAM manufacturer's JEDEC ID code, LSB02hElpida Memory02hElpida Memory149SDRAM manufacturer's JEDEC ID code, MSBFEhElpida MemoryFEhElpida Memory150 to 175Manufacturer's specific dataFEhElpida MemoryFEhElpida Memory	135	Module part number	38h	8	38h	8	38h	8
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176 to 255 Open for customer use 00h — 00h — 00h —	150 to 175	Manufacturer's specific data						
	176 to 255	Open for customer use	00h	_	00h	_	00h	_

Block Diagram





Data Sheet E1642E30 (Ver. 3.0)

ELPIDA

Electrical Specifications

• All voltages are referenced to VSS (GND).

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit	Notes
Power supply voltage	VDD	–0.4 to +1.975	V	1, 3, 4
Input voltage	VIN	–0.4 to +1.975	V	1, 4
Output voltage	VOUT	–0.4 to +1.975	V	1, 4
Reference voltage	VREFCA	–0.4 to $0.6 \times \text{VDD}$	V	3, 4
Reference voltage for DQ	VREFDQ	–0.4 to 0.6 $\times\text{VDDQ}$	V	3, 4
Storage temperature	Tstg	–55 to +100	°C	1, 2, 4
Power dissipation	PD	8	W	
Short circuit output current	IOUT	50	mA	1, 4

Notes: 1. Stresses greater than those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

2. Storage temperature is the case surface temperature on the center/top side of the DRAM.

3. VDD and VDDQ must be within 300mV of each other at all times; and VREF must be not greater than $0.6 \times$ VDDQ, When VDD and VDDQ are less than 500mV; VREF may be equal to or less than 300mV.

- 4. DDR3 SDRAM component specification.
- Caution Exposing the device to stress above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

Operating Temperature Condition

Parameter	Symbol	Rating	Unit	Notes
Operating case temperature	ТС	0 to +95	°C	1, 2, 3

Notes: 1. Operating temperature is the case surface temperature on the center/top side of the DRAM.

 The Normal Temperature Range specifies the temperatures where all DRAM specifications will be supported. During operation, the DRAM case temperature must be maintained between 0°C to +85°C under all operating conditions.

 Some applications require operation of the DRAM in the Extended Temperature Range between +85°C and +95°C case temperature. Full specifications are guaranteed in this range, but the following additional conditions apply:

a) Refresh commands must be doubled in frequency, therefore reducing the refresh interval tREFI to 3.9µs. (This double refresh requirement may not apply for some devices.)

b) If Self-refresh operation is required in the Extended Temperature Range, then it is mandatory to either use the Manual Self-Refresh mode with Extended Temperature Range capability (MR2 bit [A6, A7] = [0, 1]) or enable the optional Auto Self-Refresh mode (MR2 bit [A6, A7] = [1, 0]).

Parameter Symbol Unit min. typ. max. Notes VDD, VDDQ 1.425 1.5 1.575 V 1, 2, 3 Supply voltage 0 V 1 VSS 0 0 VDDSPD 3.0 3.3 3.6 V Input reference voltage for $0.51 \times \text{VDD}$ VREFCA (DC) $0.49 \times \text{VDD}$ _ V 1, 4, 5 address, command inputs Input reference voltage for VREFDQ (DC) $0.49 \times \text{VDD}$ $0.51 \times VDD$ V 1, 4, 5 ____ DQ, DM inputs

Recommended DC Operating Conditions (TC = 0°C to +85°C)

Notes: 1. DDR3 SDRAM component specification.

2. Under all conditions VDDQ must be less than or equal to VDD.

3. VDDQ tracks with VDD. AC parameters are measured with VDD and VDDQ tied together.

4. The AC peak noise on VREF may not allow VREF to deviate from VREF(DC) by more than \pm 1% VDD (for reference: approx \pm 15 mV).

5. For reference: approx. VDD/2 \pm 15 mV.

DC Characteristics 1 (TC = 0°C to +85°C, VDD = $1.5V \pm 0.075V$, VSS = 0V)

Data rate (Mbps)		1600	1333		
Parameter	Symbol	max.	max.	Unit	Notes
Operating current (ACT-PRE) (Another rank is in IDD2P1)	IDD0	1200	1080	mA	
Operating current (ACT-PRE) (Another rank is in IDD3N)	IDD0	1440	1280	mA	
Operating current (ACT-READ-PRE) (Another rank is in IDD2P1)	IDD1	1320	1200	mA	
Operating current (ACT-READ-PRE) (Another rank is in IDD3N)	IDD1	1560	1400	mA	
Precharge power-down standby	IDD2P1	720	640	mA	Fast PD Exit
current	IDD2P0	240	224	mA	Slow PD Exit
Precharge standby current	IDD2N	1040	960	mA	
Precharge standby ODT current	IDD2NT	1040	960	mA	
Precharge quiet standby current	IDD2Q	960	880	mA	
Active power-down current (Always fast exit)	IDD3P	720	640	mA	
Active standby current	IDD3N	1200	1040	mA	
Operating current (Burst read operating) (Another rank is in IDD2P1)	IDD4R	2200	1920	mA	
Operating current (Burst read operating) (Another rank is in IDD3N)	IDD4R	2440	2120	mA	
Operating current (Burst write operating) (Another rank is in IDD2P1)	IDD4W	2280	2000	mA	
Operating current (Burst write operating) (Another rank is in IDD3N)	IDD4W	2520	2200	mA	
Burst refresh current (Another rank is in IDD2P1)	IDD5B	2600	2480	mA	
Burst refresh current (Another rank is in IDD3N)	IDD5B	2840	2680	mA	
All bank interleave read current (Another rank is in IDD2P1)	IDD7	3160	2800	mA	
All bank interleave read current (Another rank is in IDD3N)	IDD7	3400	3000	mA	
RESET low current	IDD8	128	128	mA	

Self-Refresh Current (TC = 0°C to +85°C, VDD = $1.5V \pm 0.075V$)

Parameter	Symbol	max.	Unit	Notes
Self-refresh current normal temperature range	IDD6	160	mA	
Self-refresh current extended temperature range	IDD6ET	288	mA	
Auto self-refresh current (optional)	IDD6TC	—	mA	

Timings used for IDD and IDDQ Measurement-Loop Patterns

	DDR3-1600		DDR3-1333		
Parameter	10-10-10	11-11-11	9-9-9	Unit	
CL	10	11	9	nCK	
tCK min.	1.25	1.25	1.5	ns	
nRCD min.	10	11	9	nCK	
nRC min.	38	39	33	nCK	
nRAS min.	28	28	24	nCK	
nRP min.	10	11	9	nCK	
nFAW	24	24	20	nCK	
nRRD	5	5	4	nCK	
nRFC	88	88	74	nCK	

DC Characteristics 2 (TC = 0°C to +85°C, VDD, VDDQ = $1.5V \pm 0.075V$)

(DDR3 SDRAM Component Specification)

Parameter	Symbol	Value	Unit	Notes
Input leakage current	ILI	2	μA	$VDD \geq VIN \geq VSS$
Output leakage current	ILO	5	μΑ	$VDDQ \geq VOUT \geq VSS$

Pin Functions

CK, /CK (input pins)

CK and /CK are differential clock inputs. All address and control input signals are sampled on the crossing of the positive edge of CK and negative edge of /CK. Output (read) data is referenced to the crossings of CK and /CK (both directions of crossing).

/CS (input pins)

All commands are masked when /CS is registered high. /CS provides for external rank selection on systems with multiple ranks. /CS is considered part of the command code.

/RAS, /CAS, and /WE (input pins)

/RAS, /CAS and /WE (along with /CS) define the command being entered.

A0 to A13 (input pins)

Provided the row address for active commands and the column address for read/write commands to select one location out of the memory array in the respective bank. (A10(AP) and A12(/BC) have additional functions, see below) The address inputs also provide the op-code during mode register set commands.

[Address Pins Table]

Address (A0 to A13)

Row address (RA)	Column address (CA)	Notes
AX0 to AX13	AY0 to AY9	

A10(AP) (input pin)

A10 is sampled during read/write commands to determine whether auto-precharge should be performed to the accessed bank after the read/write operation. (high: auto-precharge; low: no auto-precharge)

A10 is sampled during a precharge command to determine whether the precharge applies to one bank (A10 = low) or all banks (A10 = high). If only one bank is to be precharged, the bank is selected by bank addresses (BA).

A12 (/BC) (input pin)

A12 is sampled during read and write commands to determine if burst chop (on-the-fly) will be performed. (A12 = high: no burst chop, A12 = low: burst chopped.)

BA0 to BA2 (input pins)

BA0, BA1 and BA2 define to which bank an active, read, write or precharge command is being applied. BA0 and BA1 also determine if a mode register is to be accessed during a MRS cycle.

[Bank Select Signal Table]

	BA0	BA1	BA2	
Bank 0	L	L	L	
Bank 1	Н	L	L	
Bank 2	L	Н	L	
Bank 3	Н	Н	L	
Bank 4	L	L	Н	
Bank 5	Н	L	Н	
Bank 6	L	Н	Н	
Bank 7	Н	Н	Н	

Remark: H: VIH. L: VIL.

CKE (input pins)

CKE high activates, and CKE low deactivates, internal clock signals and device input buffers and output drivers. Taking CKE low provides precharge power-down and self-refresh operation (all banks idle), or active power-down (row active in any bank). CKE is asynchronous for self-refresh exit. After VREF has become stable during the power-on and initialization sequence, it must be maintained for proper operation of the CKE receiver. For proper self-refresh entry and exit, VREF must be maintained to this input. CKE must be maintained high throughout read and write accesses. Input buffers, excluding CK, /CK, ODT and CKE are disabled during power-down. Input buffers, excluding CKE, are disabled during self-refresh.

DQ (input and output pins)

Bi-directional data bus.

DQS and /DQS (input and output pins)

Output with read data, input with write data. Edge-aligned with read data, centered in write data. The data strobe DQS is paired with differential signals /DQS to provide differential pair signaling to the system during READs and WRITES.

ODT (input pins)

ODT (registered high) enables termination resistance internal to the DDR3 SDRAM. When enabled, ODT is only applied to each DQ, DQS, /DQS, DM. The ODT pin will be ignored if the mode register (MR1) is programmed to disable ODT.

DM (input pins)

DM is the reference signal of the data input mask function. DMs are sampled at the cross point of DQS and /DQS.

VDD (power supply pins)

1.5V is applied. (VDD is for the internal circuit.)

VDDSPD (power supply pin)

3.3V is applied (For serial EEPROM).

VSS (power supply pins)

Ground is connected.

VTT (power supply pins)

I/O termination supply for SDRAM.

VREFDQ (power supply pin)

Reference voltage for DQ.

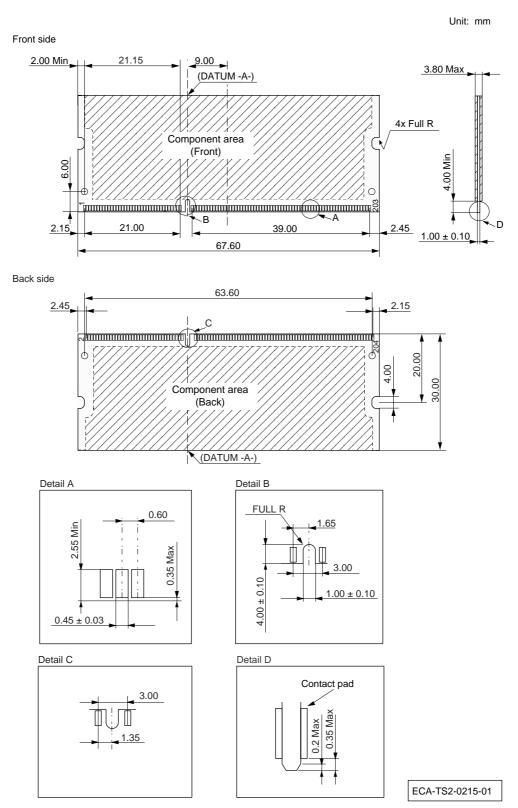
VREFCA (power supply pin)

Reference voltage for CA.

/RESET (input pin)

/RESET is negative active signal (active low) and is referred to VSS.

Physical Outline



CAUTION FOR HANDLING MEMORY MODULES

When handling or inserting memory modules, be sure not to touch any components on the modules, such as the memory ICs, chip capacitors and chip resistors. It is necessary to avoid undue mechanical stress on these components to prevent damaging them.

In particular, do not push module cover or drop the modules in order to protect from mechanical defects, which would be electrical defects.

When re-packing memory modules, be sure the modules are not touching each other. Modules in contact with other modules may cause excessive mechanical stress, which may damage the modules.

MDE0202

- NOTES FOR CMOS DEVICES -

① PRECAUTION AGAINST ESD FOR MOS DEVICES

Exposing the MOS devices to a strong electric field can cause destruction of the gate oxide and ultimately degrade the MOS devices operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it, when once it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. MOS devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. MOS devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor MOS devices on it.

(2) HANDLING OF UNUSED INPUT PINS FOR CMOS DEVICES

No connection for CMOS devices input pins can be a cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. The unused pins must be handled in accordance with the related specifications.

③ STATUS BEFORE INITIALIZATION OF MOS DEVICES

Power-on does not necessarily define initial status of MOS devices. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the MOS devices with reset function have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. MOS devices are not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for MOS devices having reset function.

CME0107



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[Product usage]

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[Usage environment]

Usage in environments with special characteristics as listed below was not considered in the design. Accordingly, our company assumes no responsibility for loss of a customer or a third party when used in environments with the special characteristics listed below.

Example:

- 1) Usage in liquids, including water, oils, chemicals and organic solvents.
- 2) Usage in exposure to direct sunlight or the outdoors, or in dusty places.
- 3) Usage involving exposure to significant amounts of corrosive gas, including sea air, CL₂, H₂S, NH₃, SO₂, and NO_x.
- 4) Usage in environments with static electricity, or strong electromagnetic waves or radiation.
- 5) Usage in places where dew forms.
- 6) Usage in environments with mechanical vibration, impact, or stress.
- 7) Usage near heating elements, igniters, or flammable items.

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